Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/828,726	COHEN ET AL.	
Examiner	Art Unit	
Frantz B. Jean	2151	

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Class	Subclass	Date	Examiner
709	217,218	4/20/2006	FJ
	245		
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717	168-178		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		-	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
West, Derwent, IBMTDBD, OCR, PGPUB, EPO, JPO	4/17/2006	fj
Inventor's search	4/17/2006	
NPL, EIC, INSPEC	4/25/2006	
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